

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10549752	YANO, ATSUYOSHI
	Examiner	Art Unit
	Faulk, Devona E	2615

SEARCHED

Class	Subclass	Date	Examiner
391	98-101	2/6/2008	DEF
704	233,267,211,278,500,501,211	2/18/2008	DEF
381	98-101	7/11/08	DEF
704	233,267,211,278,500,501	7/11/08	DEF

SEARCH NOTES

Search Notes	Date	Examiner
Assignee/Inventor search	2/6/2008	DEF
word search; combined class/word search	2/6,8,13,14,18/0 8	DEF
additional search	7/11,13/08	DEF

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner